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Huang et al.

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[54] SIMPLIFIED DUAL DAMASCENE PROCESS FOR MULTI-LEVEL METALLIZATION AND INTERCONNECTION STRUCTURE

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[73] Assignee: Advanced Micro Devices, Inc.,

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[56]

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[51]	Int. Cl. ⁶		H01L 21/44
[52]	U.S. Cl.	•••••	437/195 ; 437/190; 437/203
			156/652.1; 156/653.1
[58]	Field of	Search	437/195, 190
		437/182, 203; 1	156/DIG. 652.1, DIG. 653.1

References Cited

U.S. PATENT DOCUMENTS

3,844,831	10/1974	Cass et al	437/195
3,961,414	6/1976	Humphreys	437/195
4,472,240	9/1984	Kameyama .	
4,536,951	8/1985	Rhodes et al	437/195
4,764,484	8/1988	Mo	437/195
4,801,350	1/1989	Mattox et al	
4,933,303	6/1990	Mo	437/190
4,948,755	8/1990	Mo	437/195
4,996,167	2/1991	Chen .	
5,055,423	10/1991	Smith et al	437/195
5,093,279	3/1992	Andreshak et al	
5,262,354	11/1993	Cote et al	
5,354,711	10/1994	Heitzmann et al	437/182
5,470,788	11/1995	Biery et al	437/190
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FOREIGN PATENT DOCUMENTS

0 224 013	6/1987	European Pat. Off
0 425 787	5/1991	European Pat. Off

0 435 187	7/1991	European Pat	. Off
0 463 972	1/1992	European Pat	Off

OTHER PUBLICATIONS

Kikuta et al., "Al-Gr Reflow Sputtering For Submicron-Contact-Hole Filling", Microelectronics Research Laboratories, NEC Corporation, IEEE VMIC Conference, Jun. 11–12, 1991, pp. 5.2.1–5.2.4.

IBM Technical Disclosure Bulletin, vol. 30, No. 8, Jan 1988, New York, US, pp. 252–253, XP 000097503 Anonymous "Methods of forming small contact holes".

Proceedings of the 8th International IEEE VLSI Multilevel Interconnection Conference, Santa Clara, CA, USA, Jun. 11–12, 1991, pp. 144–152, Kaanta et al., "Dual damascene: a ULSI wiring technology".

Joshi, "A New Damascene Structure for Submicrometer Interconnect Wiring," IEEE Electron Letters, vol. 14, No. 3, Mar. 1993, pp. 129–132.

Mar. 1993, pp. 129-132. Kaanta et al., "Dual Damascene: A ULSI Wiring Technology," Jun. 11-12, 1991, VMIC Conference, IEEE, pp. 144-152.

Kenny et al., "A Buried-Plate Trench Cell for a 64-Mb DRAM," 1992 Symposium on VLSI Technology Digest of Technical Papers, IEEE, pp. 14 and 15.

Primary Examiner—Charles L. Bowers, Jr. Assistant Examiner—Lynne A. Gurley

[57] ABSTRACT

A semiconductor device containing an interconnection structure having a reduced interwiring spacing is produced by a modified dual damascene process. In one embodiment, an opening for a via is initially formed in a second insulative layer above a first insulative layer with an etch stop layer therebetween. A larger opening for a trench is then formed in the second insulative layer while simultaneously extending the via opening through the etch stop layer and first insulative layer. The trench and via are then simultaneously filled with conductive material.

13 Claims, 8 Drawing Sheets

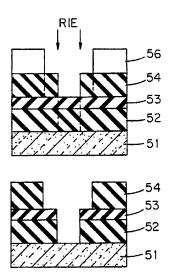




FIG. 1(a) PRIOR ART

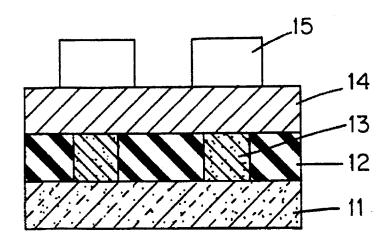


FIG. 1(b) PRIOR ART

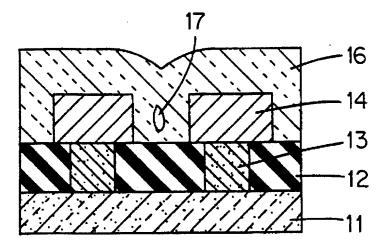


FIG. 2(a) PRIOR ART



FIG. 2(b) PRIOR ART

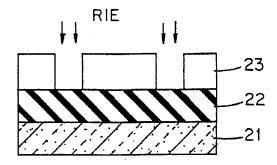


FIG. 2(c) PRIOR ART

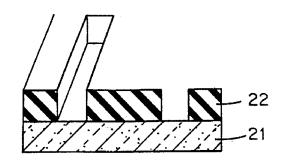
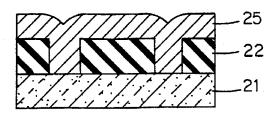


FIG. 2(d) PRIOR ART



FIG. 2(e) PRIOR ART



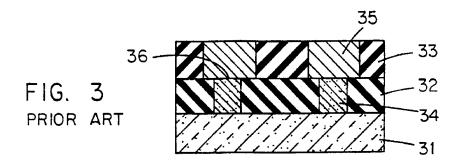


FIG. 4(a) PRIOR ART

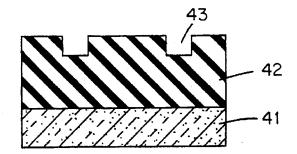


FIG. 4(b) PRIOR ART

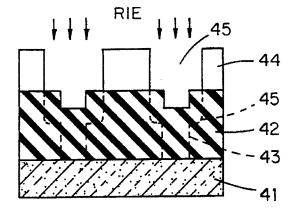


FIG. 4(c) PRIOR ART

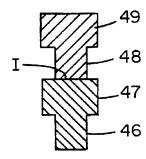


FIG. 5(a)

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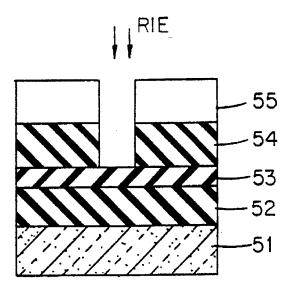


FIG. 5(b)

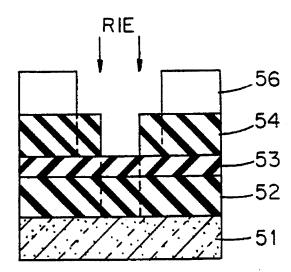
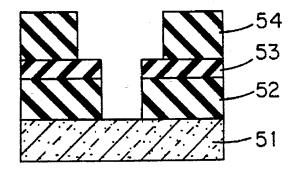


FIG. 5(c)



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